
**Geometrical product specifications
(GPS) — Filtration —**

Part 30:

Robust profile filters: Basic concepts

Spécification géométrique des produits (GPS) — Filtrage —

Partie 30: Filtres de profil robustes: Concepts de base

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: [Foreword - Supplementary information](#).

The committee responsible for this document is ISO/TC 213, *Dimensional and geometrical product specifications and verification*.

This first edition of ISO 16610-30 cancels and replaces ISO/TS 16610-30:2009, which has been technically revised.

ISO 16610 consists of the following parts, under the general title *Geometrical product specifications (GPS) — Filtration*:

- Part 1: Overview and basic concepts
- Part 20: Linear profile filters: Basic concepts
- Part 21: Linear profile filters: Gaussian filters
- Part 22: Linear profile filters: Spline filters
- Part 28: Profile filters: End effects
- Part 29: Linear profile filters: Spline wavelets
- Part 30: Robust profile filters: Basic concepts
- Part 31: Robust profile filters: Gaussian regression filters
- Part 32: Robust profile filters: Spline filters
- Part 40: Morphological profile filters: Basic concepts
- Part 41: Morphological profile filters: Disk and horizontal line-segment filters
- Part 49: Morphological profile filters: Scale space techniques
- Part 60: Linear areal filters: Basic concepts

- *Part 61: Linear areal filters: Gaussian filters*
- *Part 71: Robust areal filters: Gaussian regression filters*
- *Part 85: Morphological areal filters: Segmentation*

The following parts are planned:

- *Part 26: Linear profile filters: Filtration on nominally orthogonal grid planar data sets*
- *Part 27: Linear profile filters: Filtration on nominally orthogonal grid cylindrical data sets*
- *Part 45: Morphological profile filters: Segmentation*
- *Part 62: Linear areal filters: Spline filters*
- *Part 69: Linear areal filters: Spline wavelets*
- *Part 70: Robust areal filters: Basic concepts*
- *Part 72: Robust areal filters: Spline filters*
- *Part 80: Morphological areal filters: Basic concepts*
- *Part 81: Morphological areal filters: Sphere and horizontal planar segment filters*
- *Part 89: Morphological areal filters: Scale space techniques*

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Introduction

This part of ISO 16610 is a geometrical product specification (GPS) standard and is to be regarded as a general GPS standard (see ISO 14638). It influences chain links C and F of all chains of standards.

The ISO/GPS matrix model given in ISO 14638 gives an overview of the ISO/GPS system of which this part of ISO 16610 is a part. The fundamental rules of ISO/GPS given in ISO 8015 apply to this part of ISO 16610 and the default decision rules given in ISO 14253-1 apply to specifications made in accordance with this part of ISO 16610, unless otherwise indicated.

For more detailed information of the relation of this part of ISO 16610 to the GPS matrix model, see [Annex D](#).

This part of ISO 16610 develops the basic concepts for robust profile filters.

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Geometrical product specifications (GPS) — Filtration —

Part 30:

Robust profile filters: Basic concepts

1 Scope

This part of ISO 16610 specifies the basic concepts of robust profile filters.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 16610-1, *Geometrical product specifications (GPS) — Filtration — Part 1: Overview and basic concepts*

ISO 16610-20, *Geometrical product specifications (GPS) — Filtration — Part 20: Linear profile filters: Basic concepts*

ISO/IEC Guide 99, *International vocabulary of metrology — Basic and general concepts and associated terms (VIM)*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO/IEC Guide 99, ISO 16610-1, ISO 16610-20, and the following apply.

3.1

robustness

insensitivity of the output data against specific phenomena in the input data

Note 1 to entry: Outliers, scratches, and steps are examples of specific phenomena.

[SOURCE: ISO 16610-1, 3.9]

3.2

profile discontinuity

portion of a profile where there is a sudden change in profile properties

3.2.1

slope discontinuity

profile discontinuity (3.2) consisting of a sudden change in the slope of the profile

Note 1 to entry: See [Figure 1](#).

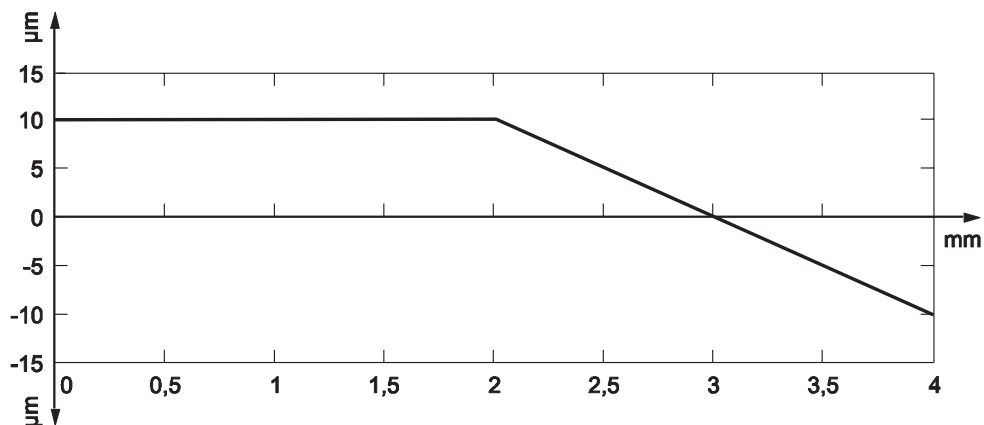


Figure 1 — Example of slope discontinuity

3.2.2

step discontinuity

profile discontinuity (3.2) consisting of a sudden change in the height of the profile

Note 1 to entry: See [Figure 2](#).

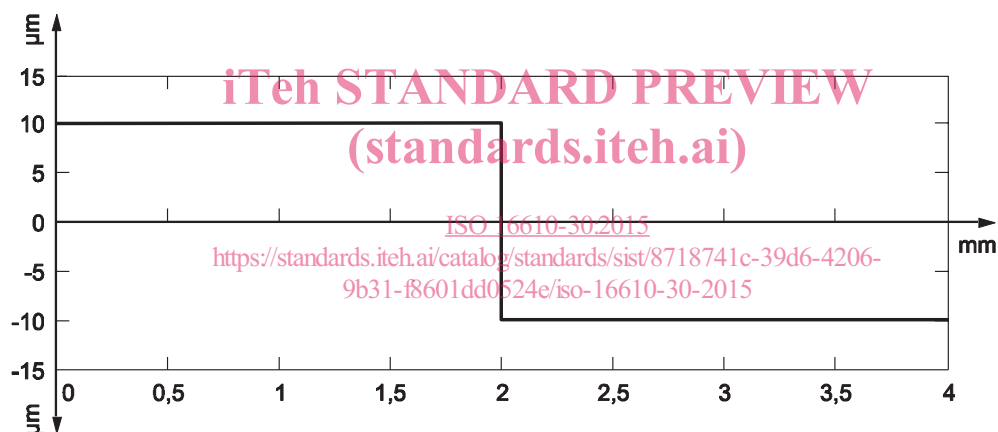


Figure 2 — Example of step discontinuity

3.2.3

spike discontinuity

profile discontinuity (3.2) consisting of an upward or downward portion of the profile with a narrow base

Note 1 to entry: See [Figure 3](#).

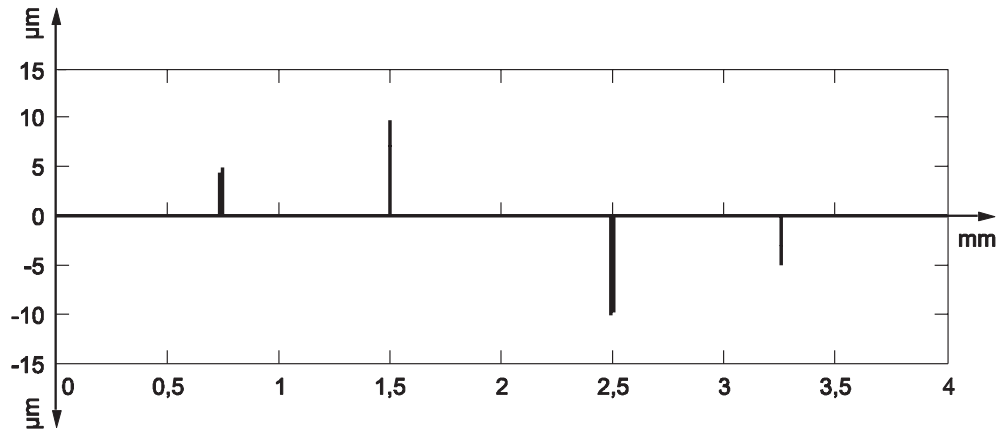


Figure 3 — Example of a series of spike discontinuities

3.3 metric

(profile) property between two profiles obeying the following three conditions:

Positivity i.e. $\delta(p_1(x), p_2(x)) \geq 0$ with equality if and only if $p_1(x) = p_2(x)$

Commutativity

$$\text{i.e. } \delta(p_1(x), p_2(x)) = \delta(p_2(x), p_1(x))$$

Triangular inequality

$$\text{i.e. } \delta(p_1(x), p_2(x)) + \delta(p_2(x), p_3(x)) \geq \delta(p_1(x), p_3(x))$$

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where $\delta(\dots, \dots)$ is a function of two profiles, p_1 and p_2 , resulting in a real number

3.3.1 norm

(profile) function of two profiles which can be used to define a *metric* (3.3)

3.3.2 L1-norm

continuous absolute deviation norm

(profile) *norm* (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \int_x |p_1(x) - p_2(x)| dx$$

3.3.3

l1-norm

discrete absolute deviation norm

(profile) *norm* (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \sum_{i=1}^n |p_1(x_i) - p_2(x_i)|$$

3.3.4

L2-norm

continuous least squares norm

(profile) norm (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \sqrt{\int_x (p_1(x) - p_2(x))^2 dx}$$

3.3.5

l2-norm

discrete least squares norm

(profile) norm (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \sqrt{\sum_{i=1}^n (p_1(x_i) - p_2(x_i))^2}$$

3.3.6

L∞-norm

continuous Chebychev norm

(profile) norm (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \max_x |p_1(x) - p_2(x)|$$

3.3.7

l∞-norm

discrete Chebychev norm

(profile) norm (3.3.1) defined by the following formula:

$$\delta(p_1(x), p_2(x)) = \max_{i=1, \dots, n} |p_1(x_i) - p_2(x_i)|$$

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3.4

statistical estimator

rule that indicates how to calculate an estimate based on sample data from a population

3.4.1

robust statistical estimator

statistical estimator (3.4) that is insensitive against specific phenomena in the input data

3.5

M-estimator

robust statistical estimator (3.4.1) which uses an influence function (3.5.1) to weight points according to their signed distance from the reference line

3.5.1

influence function

function which is asymmetric and scale invariant

Note 1 to entry: If the value of a point in the data is replaced by an arbitrary value, the influence of this modified point on the output of the M-estimator (3.5) is proportional to the influence function.

Note 2 to entry: To be scale invariant, many influence functions use a scale parameter which needs to be determined. An estimate of the dispersion of the profile from the reference line, such as median absolute deviation (3.5.2), can be used to determine the scale parameter.

3.5.2 median absolute deviation MAD

measure of dispersion of a set of observations which is robust against *spike discontinuities* (3.2.3) and computed by taking the median of the absolute deviations of each observation from the median of the observations

Note 1 to entry: For a Gaussian probability distribution, the standard deviation equals $1,482\ 6 \times \text{MAD}$.

Note 2 to entry: For additional information on the median, see Reference [10] and Reference [11].

Note 3 to entry: See Figure 4.

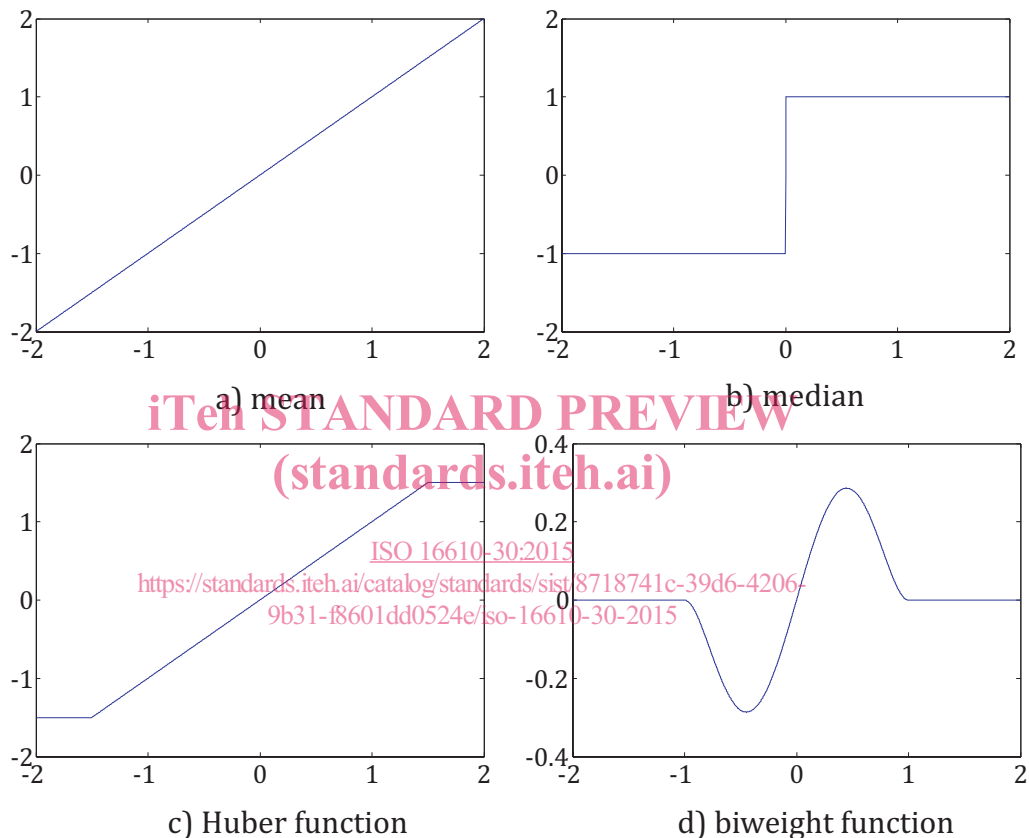


Figure 4 — Examples of influence functions that have been considered in connection with M-estimators

3.6 Bayesian estimator

robust statistical estimator (3.4.1) which uses Bayesian statistics to weight points according to their signed distance from the reference line

4 Robustness

4.1 General

Robustness is not, in general, an absolute property of a profile filter but a relative one. One can only say that a particular profile filter is more robust against a particular phenomenon than another alternative